

**Notice of References Cited**

Application/Control No.

10/618,727

Applicant(s)/Patent Under  
Reexamination  
TEUBER ET AL.

Examiner

Deborah C Lambkin

Art Unit

1626

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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